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Docket No.: 60188-782

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
Toyoji ITOU :
Serial No.: : Group Art Unit:
Filed: February 26, 2004 : Examiner:
For: METHOD FOR FABRICATION SEMICONDUCTOR DEVICE

PRELIMINARY AMENDMENT

Mail Stop Preliminary Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Prior to examination of the above-referenced application, please amend the application as follows: